

Search Notes

Application/Control No.

09/725,756

Examiner

Hai C. Pham

Applicant(s)/Patent under
Reexamination

MAKINO, HIDEYO

Art Unit

2861

SEARCHED

Class	Subclass	Date	Examiner
347	130-131, 134, 137, 233, 238	6/23/2005	HP
	241-242		
	245		
	256-257		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
347	233	6/30/2005	HP

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	6/23/2005	HP